

FORM PTO-1449
(REV. 7-80)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
12336/7:1APPLICATION NO.
10/092,343INFORMATION DISCLOSURE CITATION
(Uses several sheets if necessary)APPLICANTS: Koichi Mukasa, Makoto Sawamura,
Kazuhisa Sueoka, and Eiichi HirotaFILING DATE
March 5, 2002GROUP
2878 2881 -cmk

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
cmk	AL	2001264230 A	26.09.01	Japan	G01N	13/16	abstract only	
	AM							
	AN							
	AO							
	AP							

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

cmk	AR	K. Sueoka and K. Mukasa, <i>Development of Spin-Dependent Scanning Tunneling Microscopy</i> , School of Engineering, Hokkaido University and CREST, JST, Vol. 24, No. 12, 2000.
	AS	
	AT	

EXAMINER *Chris Kalwoda*DATE CONSIDERED *Dec 8, 2003*

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.